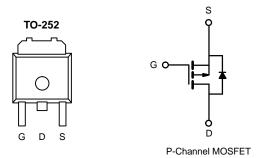


P-Channel 30-V (D-S) MOSFET

| PRODUCT SUMMARY | | | | | | |
|---------------------|------------------------------------|---------------------------------|-----------------------|--|--|--|
| V _{DS} (V) | R _{DS(on)} (Ω) | I _D (A) ^d | Q _g (Typ.) | | | |
| - 30 | 0.018 at V _{GS} = - 10 V | - 40 | 13 nC | | | |
| - 30 | 0.025 at V _{GS} = - 4.5 V | - 35 | 13110 | | | |



FEATURES

- Halogen-free According to IEC 61249-2-21
 Definition
- TrenchFET[®] Power MOSFET
- 100 % R_g Tested

APPLICATIONS

- Load Switch
- Battery Switch



Available

| Parameter | Symbol | Limit | Unit | |
|---|-----------------------------------|----------------|------------------------|----|
| Drain-Source Voltage | V _{DS} | - 30 | V | |
| Gate-Source Voltage | V _{GS} | ± 20 | v | |
| | T _C = 25 °C | | - 40 | |
| Continuous Drain Current ($T_1 = 150 \text{ °C}$) | T _C = 70 °C | | - 35 | |
| Continuous Drain Current $(T_j = 150 \text{ C})$ | T _A = 25 °C | I _D | - 30.0 ^{a, b} | |
| | T _A = 70 °C | | - 28 ^{a, b} | A |
| Pulsed Drain Current | I _{DM} | - 150 | | |
| Continuous Source-Drain Diode Current | T _C = 25 °C | 1- | - 3.5 | |
| Continuous Source-Drain Diode Current | T _A = 25 °C | I _S | - 2.1 ^{a, b} | |
| | T _C = 25 °C | | 40 | |
| Maximum Dawar Dissinction | T _C = 70 °C | D_ | 27 | w |
| Maximum Power Dissipation | T _A = 25 °C | P _D | 2.5 ^{a, b} | vv |
| | T _A = 70 °C | | 1.6 ^{a, b} | |
| Operating Junction and Storage Temperature Range | T _J , T _{stg} | - 55 to 150 | °C | |

| THERMAL RESISTANCE RATINGS | | | | | | |
|---|--------------|-------------------|---------|---------|------|--|
| Parameter | | Symbol | Typical | Maximum | Unit | |
| Maximum Junction-to-Ambient ^{a, c} | t ≤ 10 s | R _{thJA} | 40 | 50 | °C/W | |
| Maximum Junction-to-Foot | Steady State | R _{thJF} | 24 | 30 | 0,00 | |

Notes:

a. Surface mounted on 1" x 1" FR4 board.

b. t = 10 s.

c. Maximum under Steady State conditions is 95 °C/W.

d. Based on $T_C = 25$ °C.

| SPECIFICATIONS $T_J = 25 \circ C$ | C, unless oth | erwise noted | | | | |
|---|--------------------------------------|--|-------|--------------|------------|-------|
| Parameter | Symbol | Test Conditions | Min. | Тур. | Max. | Unit |
| Static | | | | | | |
| Drain-Source Breakdown Voltage | V _{DS} | V _{GS} = 0 V, I _D = - 250 μA | - 30 | | | V |
| V _{DS} Temperature Coefficient | $\Delta V_{DS}/T_{J}$ | I _D = - 250 μΑ | | - 31 | | mV/°C |
| V _{GS(th)} Temperature Coefficient | $\Delta V_{GS(th)}/T_J$ | | | 4.5 | | |
| Gate-Source Threshold Voltage | V _{GS(th)} | $V_{DS} = V_{GS}, I_{D} = -250 \ \mu A$ | - 1.0 | | - 2.5 | V |
| Gate-Source Leakage | I _{GSS} | $V_{DS} = 0 V, V_{GS} = \pm 20 V$ | | | ± 100 | nA |
| Zero Gate Voltage Drain Current | I _{DSS} | $V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}$ $V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 55 \text{ °C}$ | | | - 1 - 5 | μA |
| On-State Drain Current ^a | I _{D(on)} | $V_{DS} \le -5 \text{ V}, V_{GS} = -10 \text{ V}$ | - 40 | | | A |
| Drain-Source On-State Resistance ^a | R _{DS(on)} | $V_{GS} = -10 \text{ V}, \text{ I}_{D} = -7.0 \text{ A}$ $V_{GS} = -4.5 \text{ V}, \text{ I}_{D} = -5.6 \text{ A}$ | | 0.018 | | Ω |
| Forward Transconductance ^a | 9 _{fs} | V _{DS} = - 15 V, I _D = - 7.0 A | | 18 | | S |
| Dynamic ^b | | | 1 | | | |
| Input Capacitance | C _{iss} | | | 1455 | | pF |
| Output Capacitance | C _{oss} | V _{DS} = - 15 V, V _{GS} = 0 V, f = 1 MHz | | 180 | | |
| Reverse Transfer Capacitance | C _{rss} | | | 145 | | |
| Total Gate Charge | Qg | V _{DS} = - 15 V, V _{GS} = - 10 V, I _D = - 7.0 A | | 25 13 | 38 20 | |
| Gate-Source Charge | Q _{gs} | V _{DS} = - 15 V, V _{GS} = - 4.5 V, I _D = - 7.0 A | | 3.5 | 20 | nC |
| Gate-Drain Charge | Q _{gs} Q _{gd} | $v_{\rm DS} = -10$ V, $v_{\rm GS} = -4.5$ V, $v_{\rm D} = -7.0$ A | | 5.5 | | |
| Gate Resistance | R _q | f = 1 MHz | 0.4 | 2.0 | 4.0 | Ω |
| Turn-On Delay Time | 0 | 1 = 1 1011 12 | 0.4 | 10 | 20 | 52 |
| Rise Time | t _{d(on)} t _r | $V_{DD} = -15 \text{ V}, \text{ R}_1 = 2.7 \Omega$ | | 10 | 20 | _ |
| Turn-Off DelayTime | | $I_D \cong -5.6 \text{ A}, \text{ V}_{\text{GEN}} = -10 \text{ V}, \text{ R}_{\text{g}} = 1 \Omega$ | | 23 | 35 | - |
| Fall Time | t _{d(off)} | 10 = -3.0 A, VGEN = -10 V, Vg = 1.32 | | 23 9 | 18 | _ |
| Turn-On Delay Time | t _f | | | 38 | 57 | ns |
| Rise Time | t _{d(on)} | $V_{DD} = -15 \text{ V}, \text{ R}_1 = 2.7 \Omega$ | | - 30 - 89 | 134 | _ |
| Turn-Off DelayTime | t _r | $V_{DD} = -15 \text{ V}, \text{ K}_{L} = 2.7 \Omega^{2}$ $I_{D} \cong -5.6 \text{ A}, \text{ V}_{\text{GEN}} = -4.5 \text{ V}, \text{ R}_{\text{g}} = 1 \Omega$ | | 22 | 33 | 4 |
| Fall Time | t _{d(off)} | $D = -3.0 \text{ A}, V_{\text{GEN}} = -4.3 \text{ V}, V_{\text{g}} = 1.22$ | | 11 | 33 17 | |
| | t _f | | | 11 | 17 | |
| Drain-Source Body Diode Characteris | | T 05 %0 | [| | 0.5 | r |
| Continous Source-Drain Diode Current | I _S | T _C = 25 °C | | | - 6.5 | A |
| Pulse Diode Forward Current | I _{SM} | | | 0.74 | - 30 | |
| Body Diode Voltage | V _{SD} | I _S = - 5.6 A, V _{GS} = 0 V | | - 0.71 | - 1.2 | V |
| Body Diode Reverse Recovery Time | t _{rr} | 4 | | 22 | 33 | ns |
| Body Diode Reverse Recovery Charge | Q _{rr} | I _F = - 5.6 A, dl/dt = 100 A/μs, T _{.1} = 25 °C | - | 17 | 26 | nC |
| Reverse Recovery Fall Time | t _a | | | 13 | | ns |
| Reverse Recovery Rise Time | t _b | | | 9 | | |

Notes:

a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.

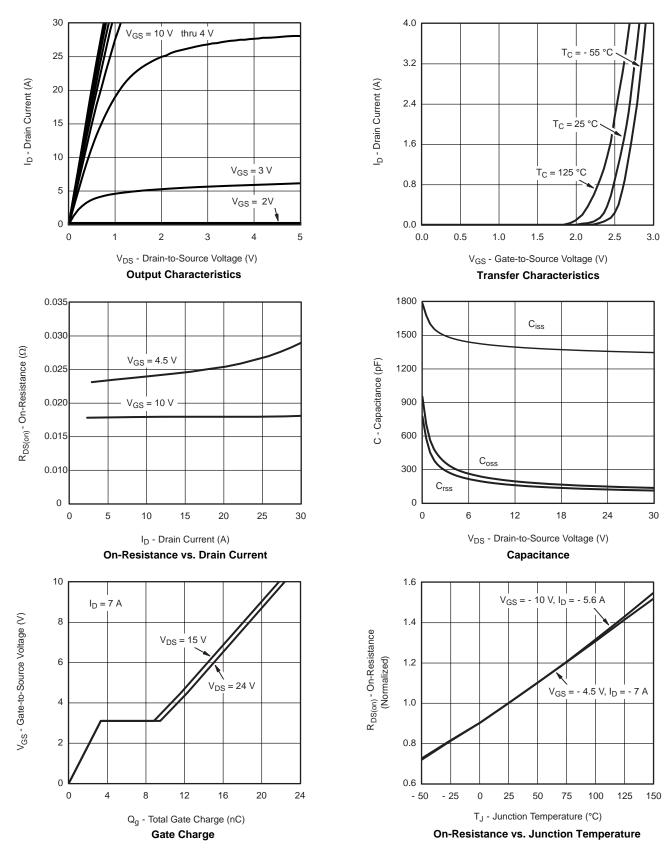
b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

emi

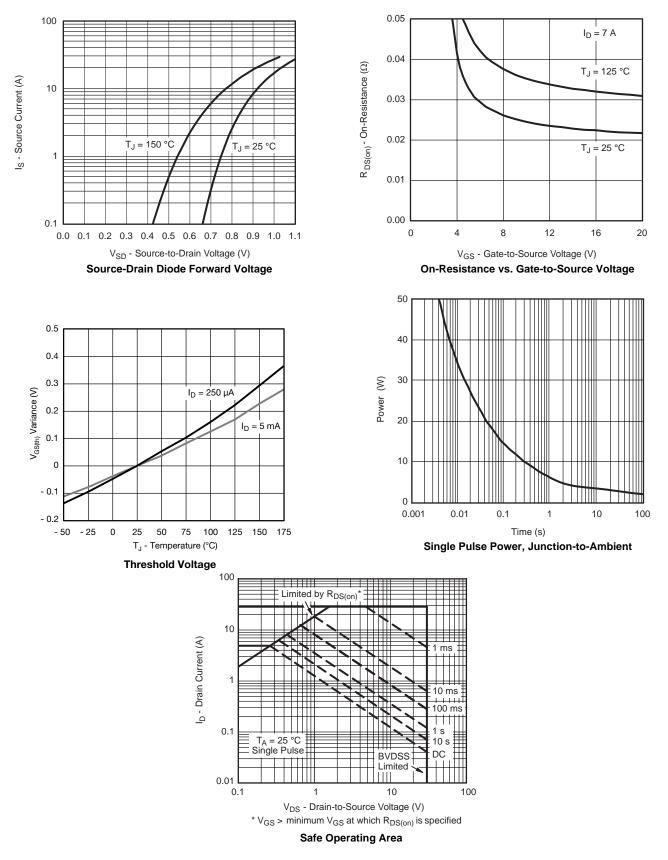


TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



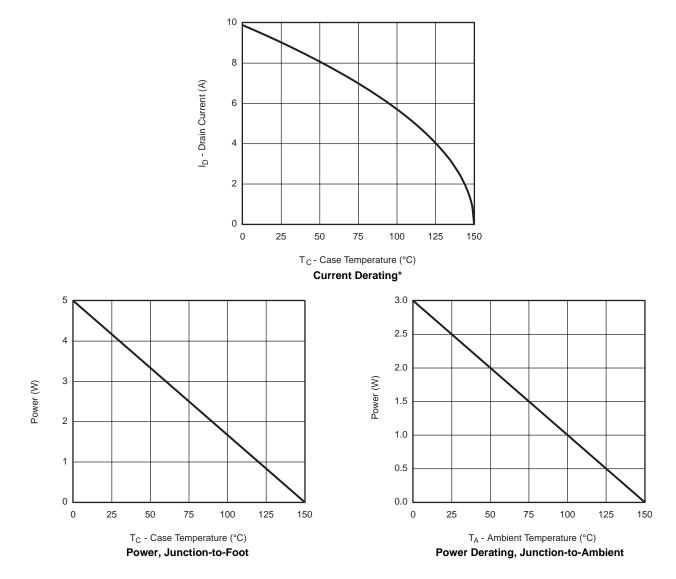


TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted





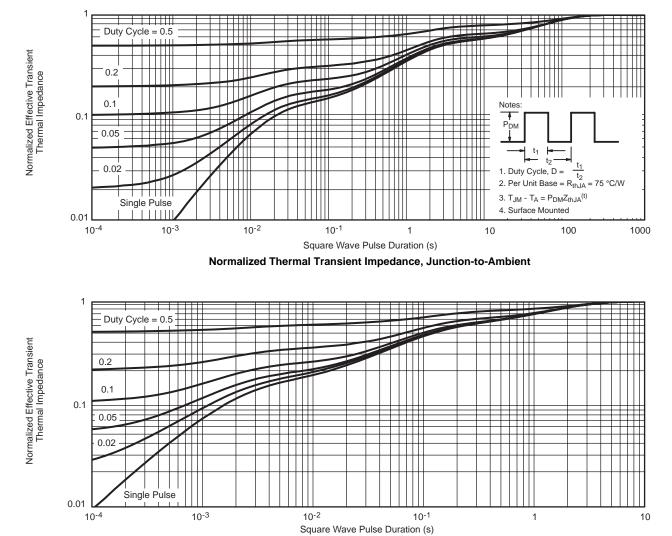
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



* The power dissipation P_D is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

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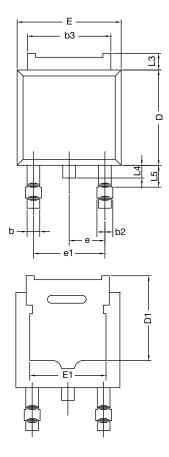
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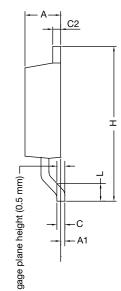


Normalized Thermal Transient Impedance, Junction-to-Foot



TO-252AA CASE OUTLINE





| | MILLIN | IETERS | INC | HES | |
|--|----------|--------|-----------|-------|--|
| DIM. | MIN. | MAX. | MIN. | MAX. | |
| А | 2.18 | 2.38 | 0.086 | 0.094 | |
| A1 | - | 0.127 | - | 0.005 | |
| b | 0.64 | 0.88 | 0.025 | 0.035 | |
| b2 | 0.76 | 1.14 | 0.030 | 0.045 | |
| b3 | 4.95 | 5.46 | 0.195 | 0.215 | |
| С | 0.46 | 0.61 | 0.018 | 0.024 | |
| C2 | 0.46 | 0.89 | 0.018 | 0.035 | |
| D | 5.97 | 6.22 | 0.235 | 0.245 | |
| D1 | 5.21 | - | 0.205 | - | |
| Е | 6.35 | 6.73 | 0.250 | 0.265 | |
| E1 | 4.32 | - | 0.170 | - | |
| Н | 9.40 | 10.41 | 0.370 | 0.410 | |
| е | 2.28 BSC | | 0.090 BSC | | |
| e1 | 4.56 BSC | | 0.180 | BSC | |
| L | 1.40 | 1.78 | 0.055 | 0.070 | |
| L3 | 0.89 | 1.27 | 0.035 | 0.050 | |
| L4 | - | 1.02 | - | 0.040 | |
| L5 | 1.14 | 1.52 | 0.045 | 0.060 | |
| ECN: X12-0247-Rev. M, 24-Dec-12 DWG: 5347 | | | | | |

Note

• Dimension L3 is for reference only.



RECOMMENDED MINIMUM PADS FOR DPAK (TO-252)



Recommended Minimum Pads Dimensions in Inches/(mm)



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